Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/815,516	CAIN ET AL.
Examiner	Art Unit
Alan S. Chen	2182

SEARCHED				
Class	Subclass	Date	Examiner	
710	15	10/10/2006	ASC	
	16			
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M-20-11-20-12-1				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
·	DATE	EXMR		
(EAST) USPAT; USPGPUB; EPO; JPO; IBM_TDB; DERWENT	10/10/2006	ASC		
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